Application/Control No. Applicant(s)/Patent Under Reexamination 09/899,984 HEUER, VOLKMAR Notice of References Cited Examiner Art Unit Page 1 of 1 John L. Shew 2664 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,307,859 B1 10-2001 Tedenstig, Ove 370/401 Α US-6,643,464 B1 11-2003 Roorda et al. В 398/59 US-C D US-US-Ε US-F US-G US-Н US-US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Code-Number-Kind Code Country Name Classification MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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